

4.5A, 500V, 1.500 Ohm, N-Channel Power MOSFET

This N-Channel enhancement mode silicon gate power field effect transistor is an advanced power MOSFET designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching convertors, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

Formerly developmental type TA17415.

Ordering Information

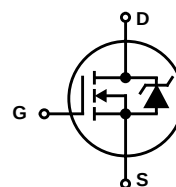
PART NUMBER	PACKAGE	BRAND
IRF430	TO-204AA	IRF430

NOTE: When ordering, use the entire part number.

Features

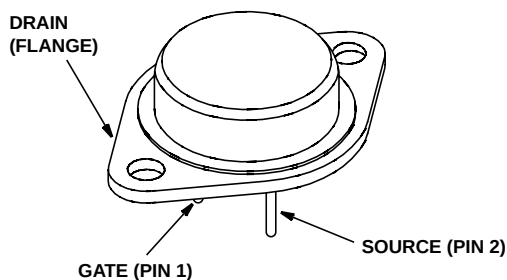
- 4.5A, 500V
- $r_{DS(ON)} = 1.500\Omega$
- Single Pulse Avalanche Energy Rated
- SOA is Power Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance
- Related Literature
 - TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"

Symbol



Packaging

JEDEC TO-204AA



Absolute Maximum Ratings

$T_C = 25^{\circ}\text{C}$, Unless Otherwise Specified

	IRF430	UNITS
Drain to Source Breakdown Voltage (Note 1)	V_{DS} 500	V
Drain to Gate Voltage ($R_{GS} = 20\text{k}\Omega$) (Note 1)	V_{DGR} 500	V
Continuous Drain Current	I_D 4.5	A
$T_C = 100^{\circ}\text{C}$	I_D 3.0	A
Pulsed Drain Current (Note 3)	I_{DM} 18	A
Gate to Source Voltage	V_{GS} ± 20	V
Maximum Power Dissipation	P_D 75	W
Dissipation Derating Factor	0.6	$\text{W}/^{\circ}\text{C}$
Single Pulse Avalanche Energy Rating (Note 4)	E_{AS} 300	mJ
Operating and Storage Temperature	T_J, T_{STG} -55 to 150	$^{\circ}\text{C}$
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10s.	T_L 300	$^{\circ}\text{C}$
Package Body for 10s, See Techbrief 334	T_{pkg} 260	$^{\circ}\text{C}$

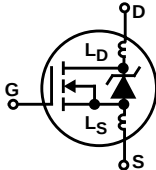
CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. $T_J = 25^{\circ}\text{C}$ to 125°C .

Electrical Specifications

$T_C = 25^{\circ}\text{C}$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage	BV _{DSS}	I _D = 250μA, V _{GS} = 0V (Figure 10)		500	-	-	V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D = 250μA		2.0	-	4.0	V
Gate to Source Leakage Current	I _{GSS}	V _{GS} = ±20V				±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = Rated BV _{DSS} , V _{GS} = 0V		-	-	25	μA
		V _{DS} = 0.8 x Rated BV _{DSS} , V _{GS} = 0V, T _J = 125°C		-	-	250	μA
On-State Drain Current (Note 2)	I _{D(ON)}	V _{DS} > I _{D(ON)} × r _{DS(ON)MAX} , V _{GS} = 10V (Figure 7)		4.5	-	-	A
Drain to Source On Resistance (Note 2)	r _{DS(ON)}	I _D = 2.5A, V _{GS} = 10V (Figures 8, 9)		-	1.3	1.500	Ω
Forward Transconductance (Note 2)	g _{fs}	V _{DS} ≥ 10V, I _D = 2.7A (Figure 12)		2.5	3.2	-	S
Turn-On Delay Time	t _{d(ON)}	V _{DD} = 250V, I _D ≈ 4.5A, R _G = 12Ω, R _L = 50Ω (Figures 17, 18) MOSFET Switching Times are Essentially Independent of Operating Temperature	-	11	17	ns	
Rise Time	t _r		-	15	23	ns	
Turn-Off Delay Time	t _{d(OFF)}		-	35	53	ns	
Fall Time	t _f		-	15	23	ns	
Total Gate Charge (Gate to Source + Gate to Drain)	Q _{g(TOT)}	V _{GS} = 10V, I _D ≈ 6.0A, V _{DS} = 0.8 x Rated BV _{DSS} , I _{g(REF)} = 1.5mA (Figures 14, 19, 20) Gate Charge is Essentially Independent of Operating Temperature		-	22	32	nC
Gate to Source Charge	Q _{gs}			-	3.5	-	nC
Gate to Drain “Miller” Charge	Q _{gd}			-	11	-	nC
Input Capacitance	C _{ISS}	V _{DS} = 25V, V _{GS} = 0V, f = 1MHz (Figure 11)		-	600	-	pF
Output Capacitance	C _{OSS}			-	100	-	pF
Reverse Transfer Capacitance	C _{RSS}			-	30	-	pF
Internal Drain Inductance	L _D	Measured between the Contact Screw on the Flange that is Closer to Source and Gate Pins and the Center of Die		-	5.0	-	nH
Internal Source Inductance	L _S	Measured from the Source Lead, 6mm (0.25in) from the Flange and the Source Bonding Pad		-	12.5	-	nH
Thermal Resistance Junction to Case	R _{θJC}			-	-	0.83	°C/W
Thermal Resistance Junction to Ambient	R _{θJA}	Free Air Operation		-	-	30	°C/W

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Continuous Source to Drain Current	I_{SD}	Modified MOSFET Symbol Showing the Integral Reverse P-N Junction Diode	-	-	4.5	A
Pulse Source to Drain Current (Note 3)	I_{SDM}		-	-	18	A
Source to Drain Diode Voltage (Note 2)	V_{SD}	$T_J = 25^{\circ}\text{C}$, $I_{SD} = 4.5\text{A}$, $V_{GS} = 0\text{V}$ (Figure 13)	-	-	1.4	V
Reverse Recovery Time	t_{rr}	$T_J = 25^{\circ}\text{C}$, $I_{SD} = 4.5\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	180	370	760	ns
Reverse Recovery Charge	Q_{RR}	$T_J = 25^{\circ}\text{C}$, $I_{SD} = 4.5\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	0.96	2	4.3	μC

NOTES:

- Pulse test: pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
- Repetitive rating: pulse width limited by Max junction temperature. See Transient Thermal Impedance curve (Figure 3).
- $V_{DD} = 50\text{V}$, starting $T_J = 25^{\circ}\text{C}$, $L = 25\text{mH}$, $R_G = 25\Omega$, peak $I_{AS} = 4.5\text{A}$. See Figures 15, 16.

Typical Performance Curves Unless Otherwise Specified

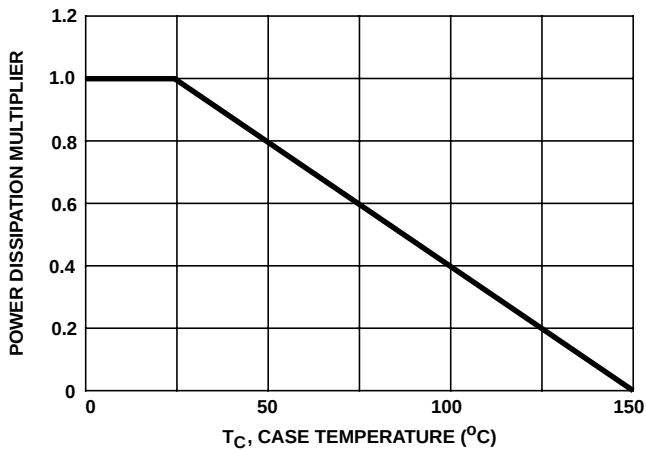


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

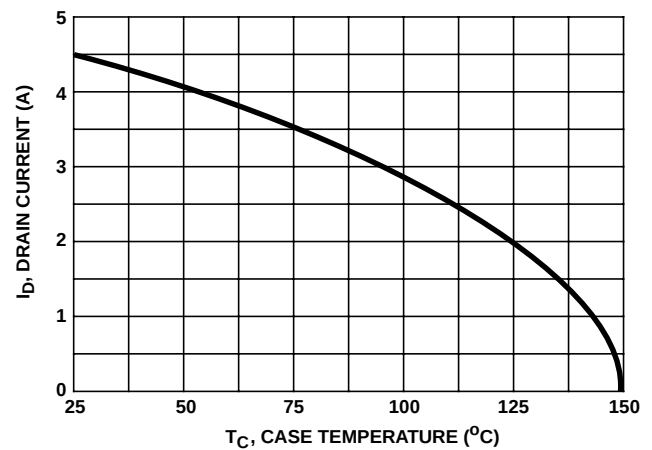


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

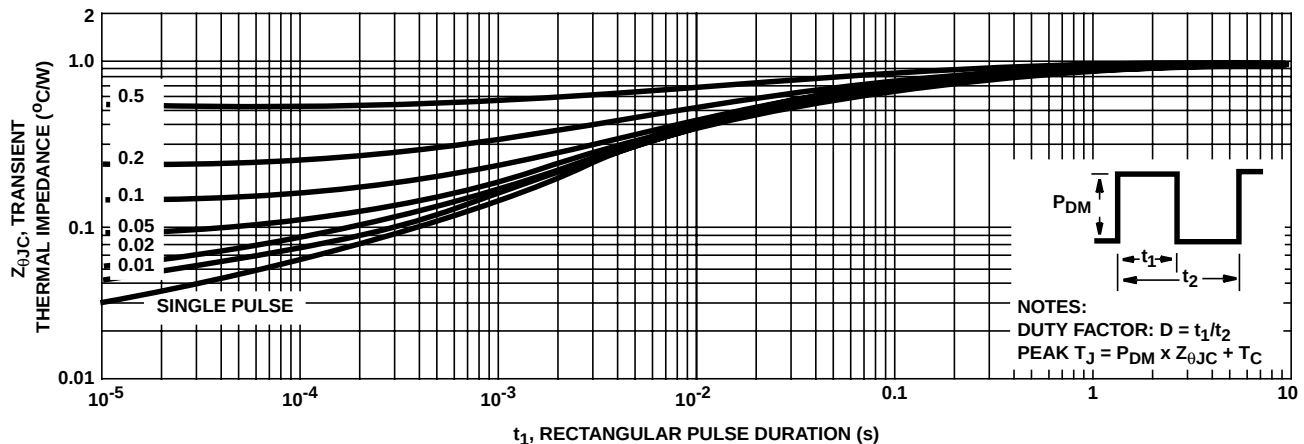


FIGURE 3. MAXIMUM TRANSIENT THERMAL IMPEDANCE

Typical Performance Curves Unless Otherwise Specified (Continued)

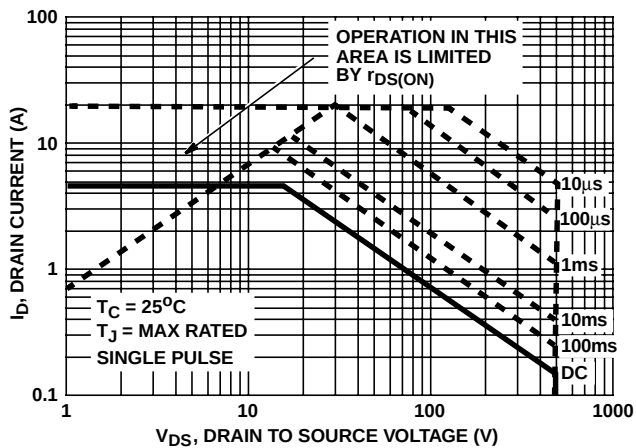


FIGURE 4. FORWARD BIAS SAFE OPERATING AREA

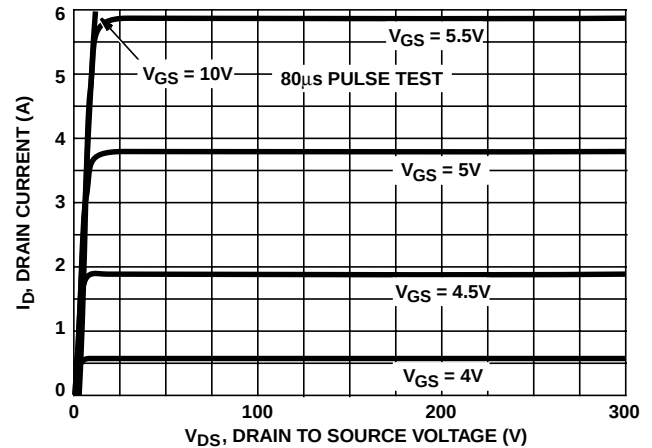


FIGURE 5. OUTPUT CHARACTERISTICS

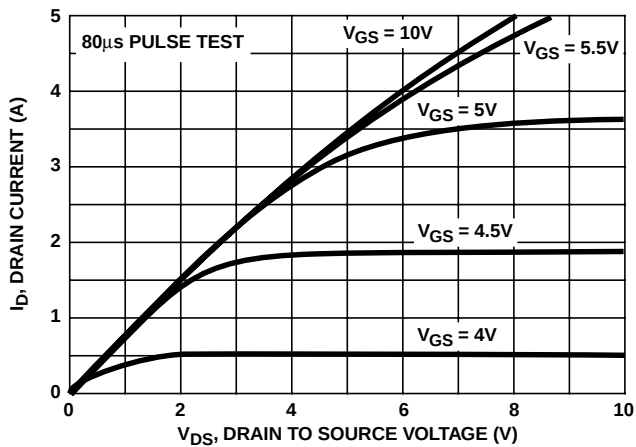


FIGURE 6. SATURATION CHARACTERISTICS

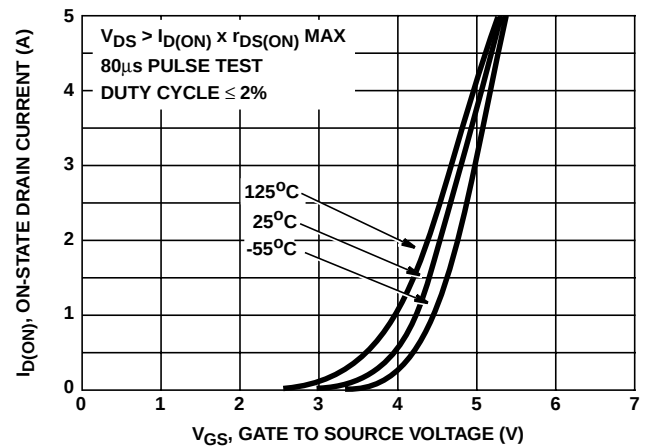
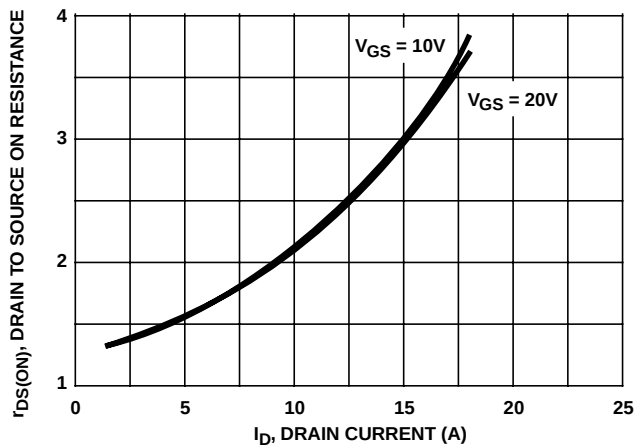


FIGURE 7. TRANSFER CHARACTERISTICS



NOTE: Heating effect of 2μs pulse is minimal.

FIGURE 8. DRAIN TO SOURCE ON RESISTANCE vs GATE VOLTAGE AND DRAIN CURRENT

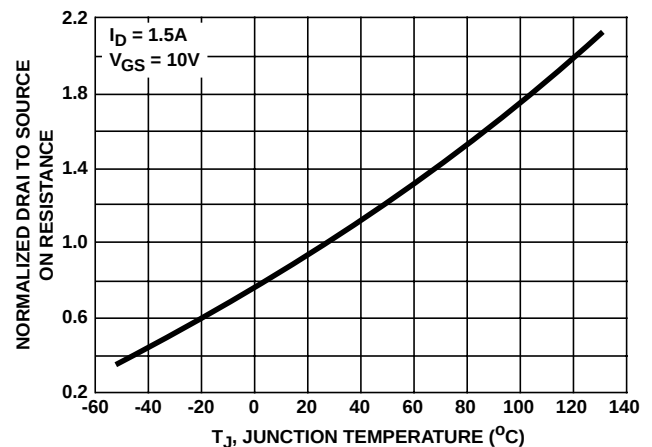


FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

Typical Performance Curves Unless Otherwise Specified (Continued)

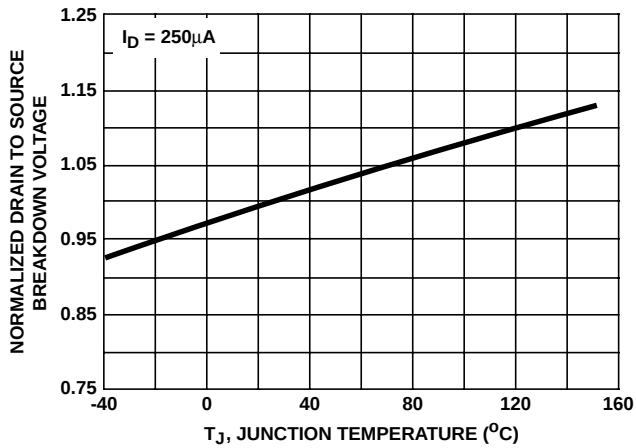


FIGURE 10. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

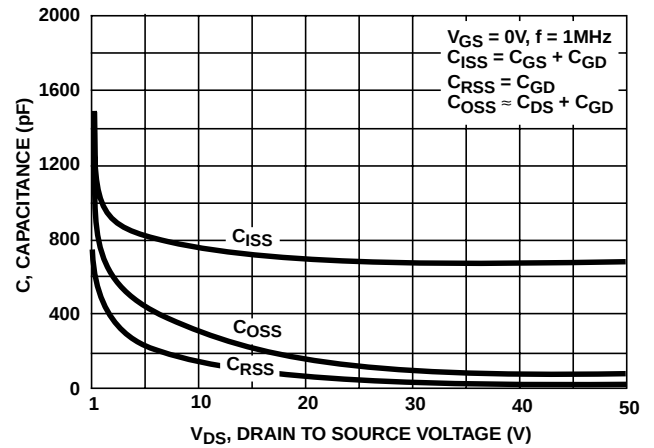


FIGURE 11. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE

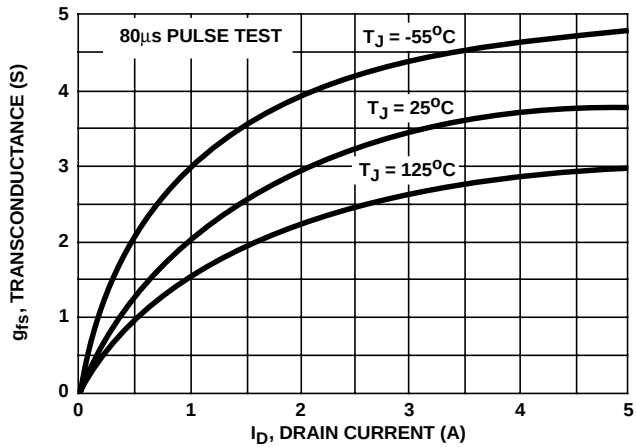


FIGURE 12. TRANSCONDUCTANCE vs DRAIN CURRENT

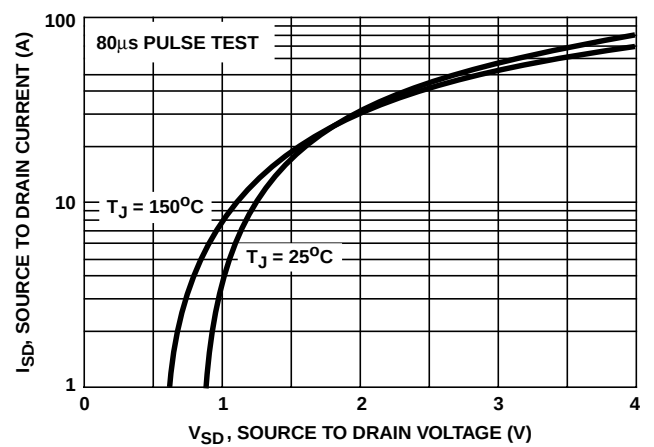


FIGURE 13. SOURCE TO DRAIN DIODE VOLTAGE

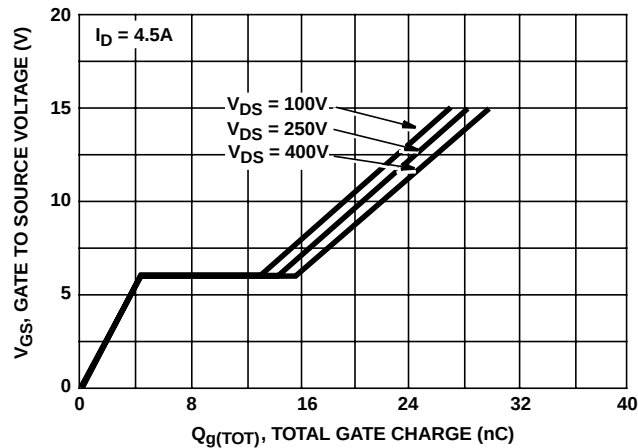


FIGURE 14. GATE TO SOURCE VOLTAGE vs GATE CHARGE

Test Circuits and Waveforms

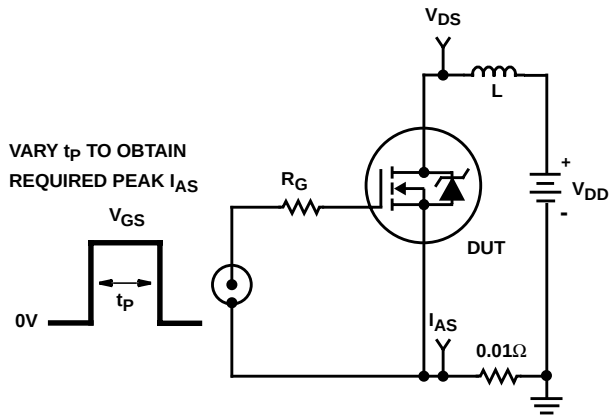


FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

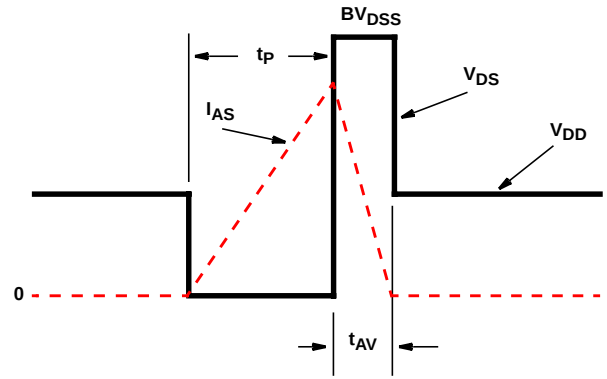


FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

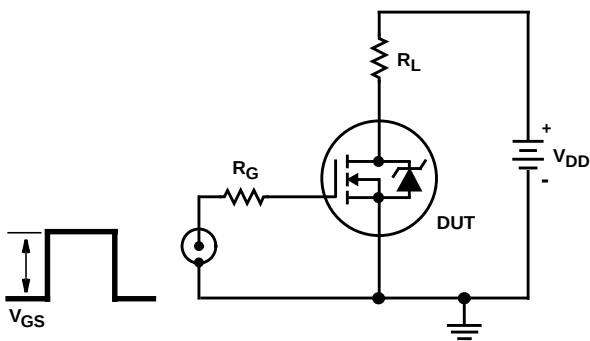


FIGURE 17. SWITCHING TIME TEST CIRCUIT

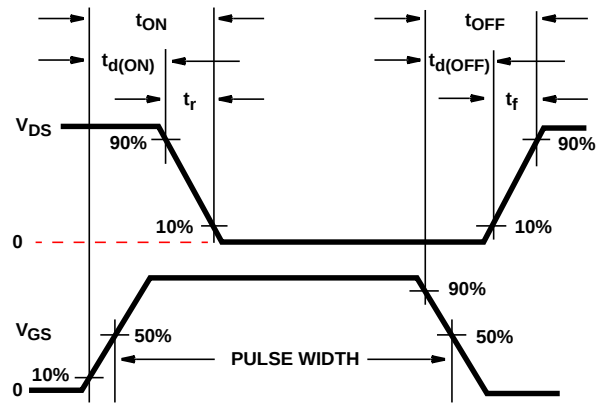


FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

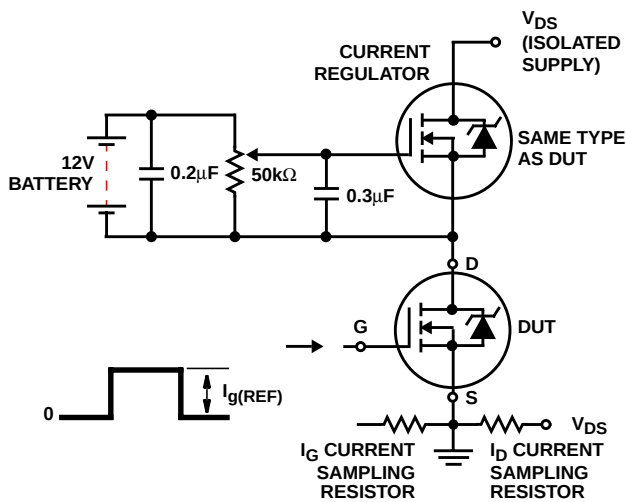


FIGURE 19. GATE CHARGE TEST CIRCUIT

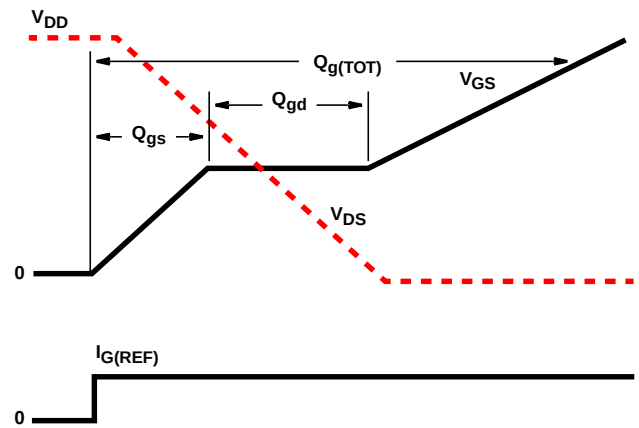


FIGURE 20. GATE CHARGE WAVEFORMS

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